


<b>Search Notes</b> 	<b>Application/Control No.</b> 10799974	<b>Applicant(s)/Patent Under Reexamination</b> KWAK ET AL.
	<b>Examiner</b> Duc T Duong	<b>Art Unit</b> 2419

SEARCHED			
Class	Subclass	Date	Examiner
370	328,338,400,401	1/2/09	DTD
455	13.4,151.1,154.1,522,41.2,41.3,67.11,67.13,226.1-226.4	1/2/09	DTD

SEARCH NOTES		
Search Notes	Date	Examiner
East text	1/2/09	DTD
see Raymond Dean, Lee Nguyen, Yuwen Pan	1/14/09	DTD
IEEE	1/14/09	DTD

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner

/D. T. D. /  
Examiner, Art Unit 2419